Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/711,035	CHEN ET AL.	
Examiner	Art Unit	
W. Patty Chen	2871	

	SEARCHED				
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted Primary Examiner Andrew Schechter in 349/153,154,190,192 search fields	9/20/2006	WPC		
349/153,154,190,192 combined with key words search of all databases in EAST	9/20/2006	WPC		
key words search of all databases in EAST	9/20/2006	WPC		